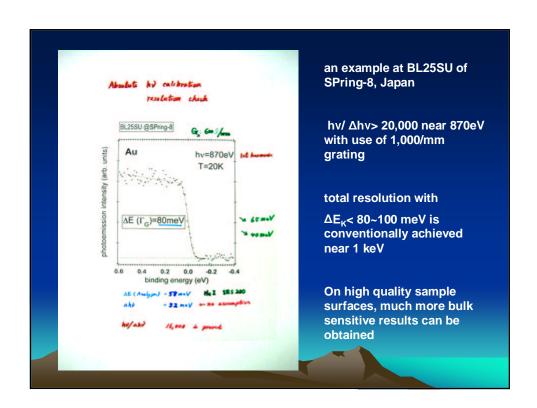
of correlated electron
systems by the soft X-ray
excitation, revealing
genuine bulk electronic
structures:

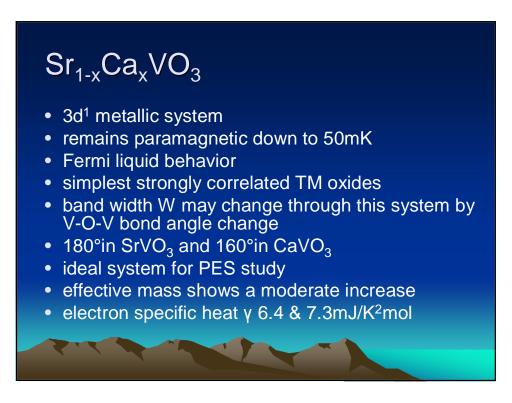
Examples of Sr_{1-x}Ca_xVO₃ and Ce compounds
by Shigemasa SUGA
Graduate School of Engineering Science
Osaka University
suga@mp.es.osaka-u.ac.jp

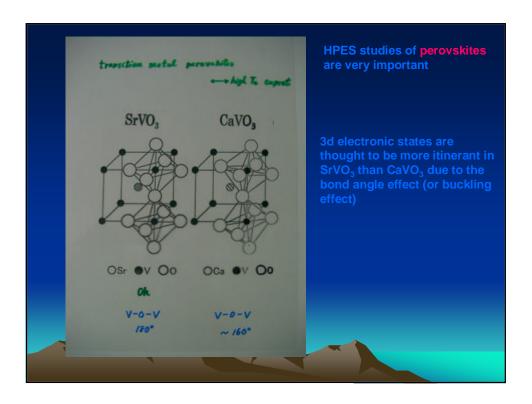


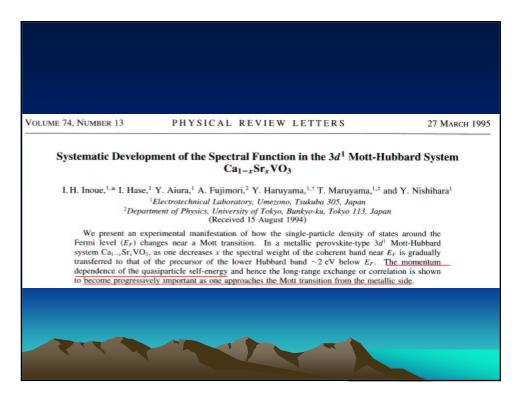
Role of High Resolution Photoemission Spectroscopy (PES) in the soft X-ray region

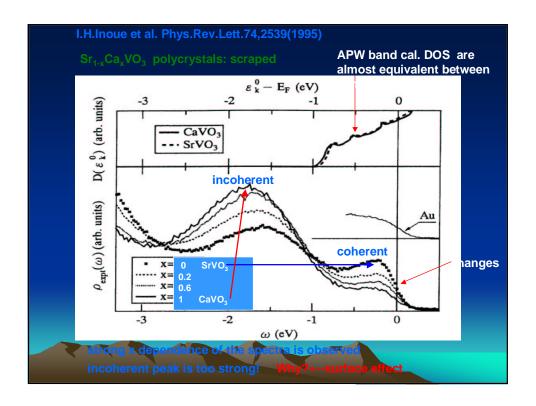
- In many materials with strong electron correlation, bulk and surface electronic structures are different
- For theoretical analyses are required reliable knowledge on genuine bulk and surface electronic structures
- High resolution spectra on high quality samples are required
- By use of the state-of-the-art soft X-ray PES technique, such studies are now feasible

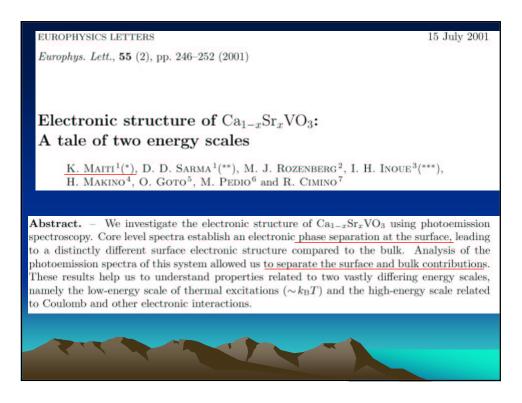


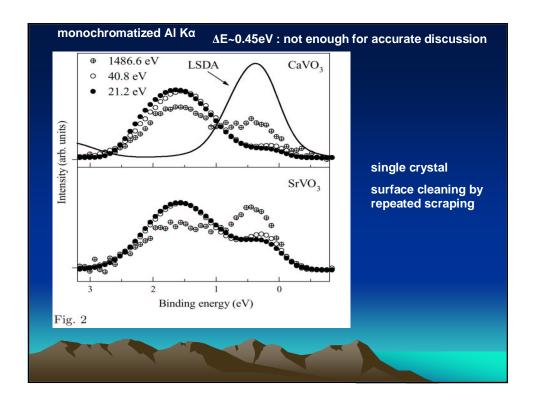


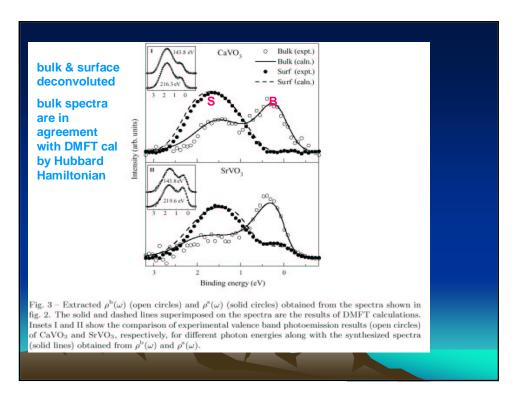


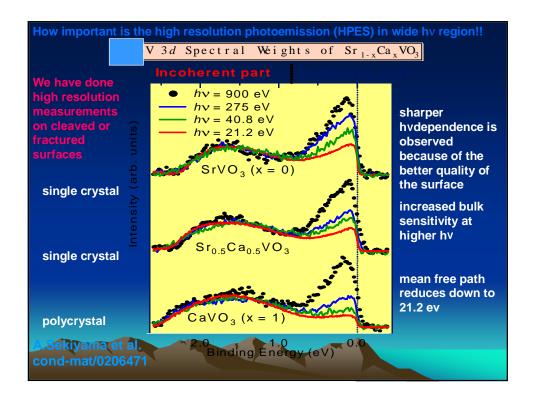


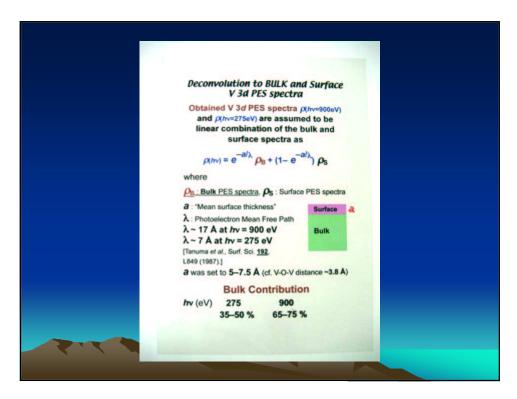


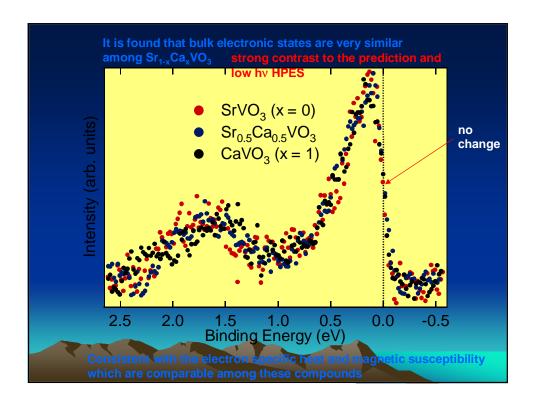


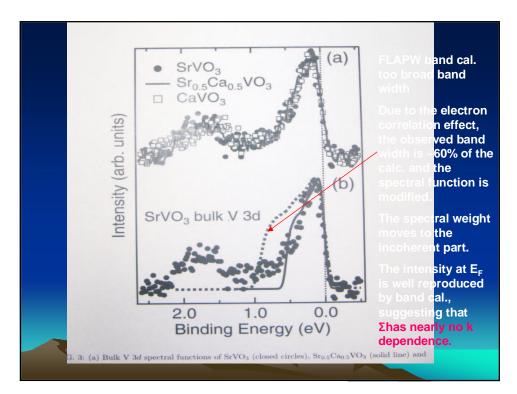


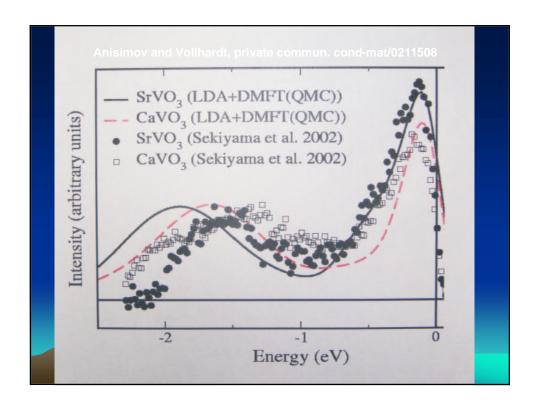


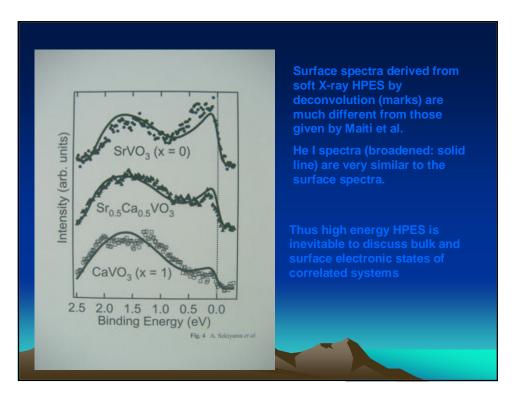


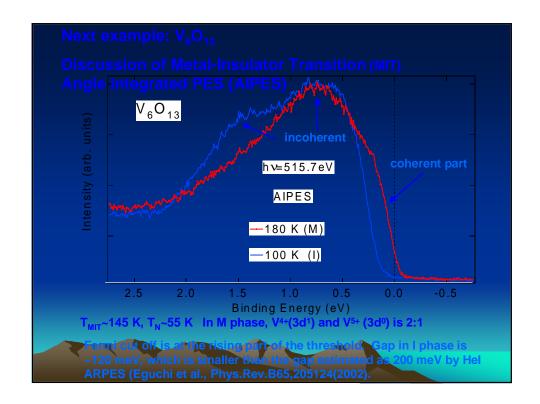




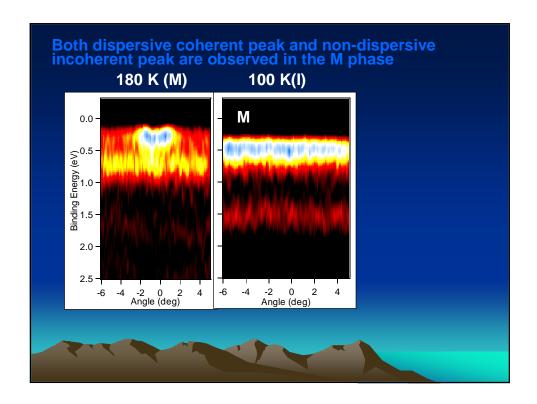


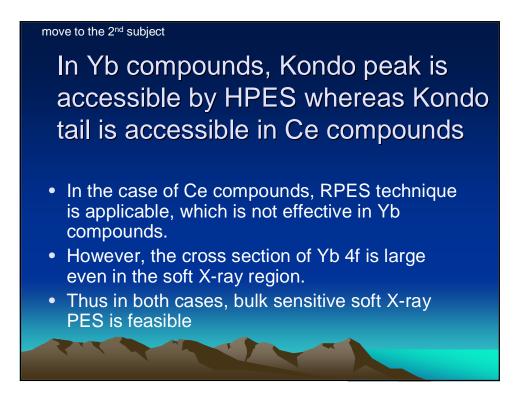


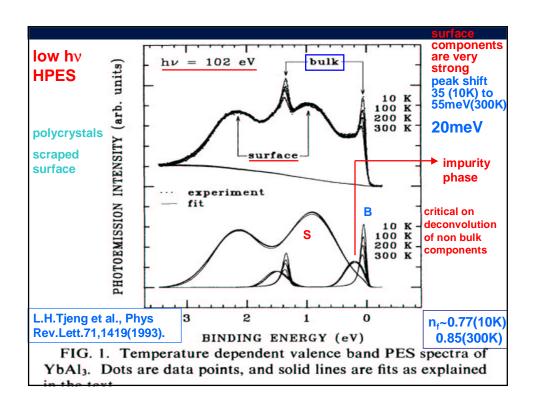


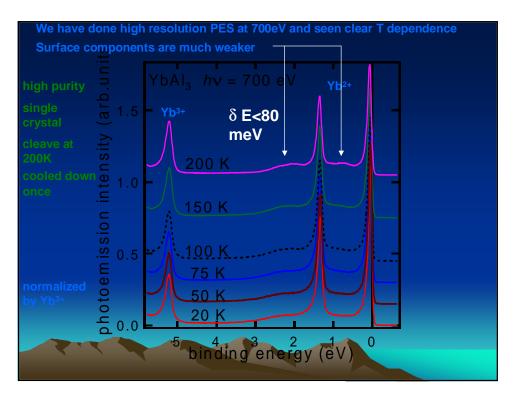


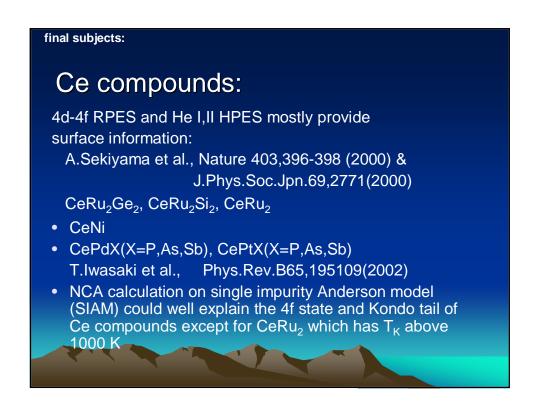
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Condition for high energy ARPES high resolution in energy & \theta (\Delta\theta<±0.2°) photon wave vector q=2\pi/\lambda hv=1,000eV • \lambda • 12A • q=0.52A-1 q.=0.37A-1 for \theta=45° incidence k<sub>B</sub>=\pi/a =0.63(1.05)A-1 for a=5(3)A q.•30(18)% of 2k<sub>B</sub> photoelectron k.=0.51(A-1)(E<sub>K</sub>(eV))<sup>1/2</sup>sin\theta E<sub>K</sub>=1,000eV • k.=16.1 sin\theta q.=0.37A-1 • sin\theta=0.37/16.1=0.023 \theta • 1.3°(k.=0 electron emission offset) 2k<sub>B</sub> (1.26A-1) \Leftrightarrow 4.4° alignative solution \Delta\theta=0.2° • \Deltak.=0.056(A-1) • 0.045*2k<sub>B</sub>
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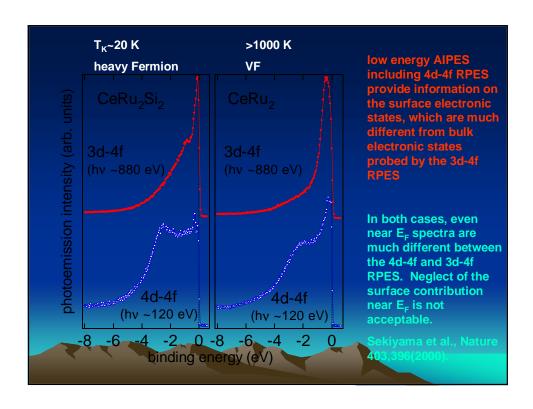


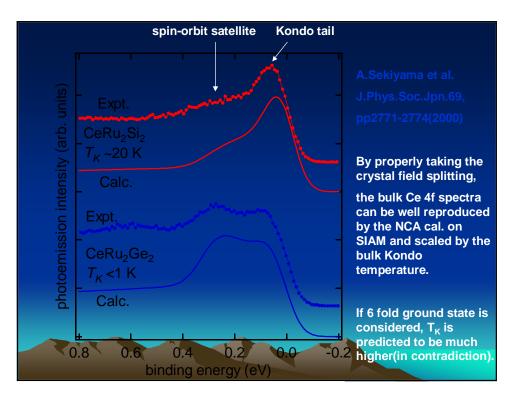


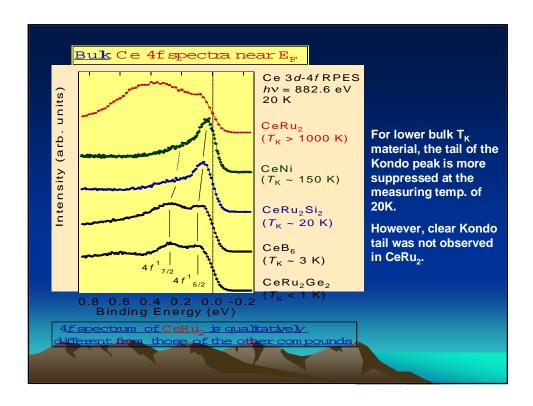
In very low T_K systems, one may think that the surface localized 4f states are not much different from the bulk electronic states, which are already localized to some extent.

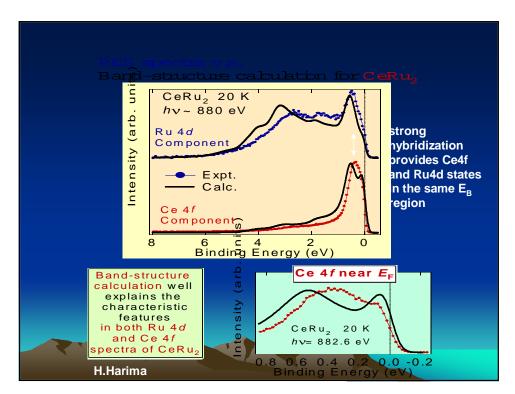
One may also claim that the spectra near the E_F are not much influenced by the surface effects, because the surface states are located in the deeper E_B .

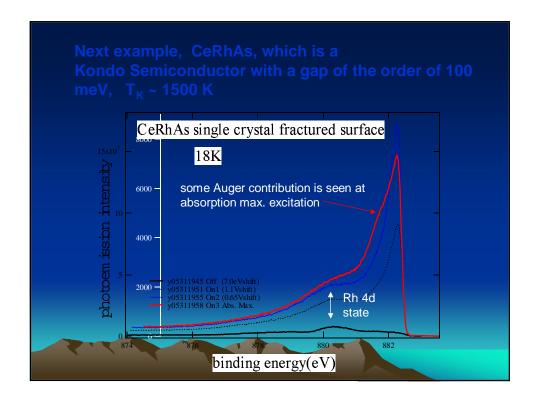
These speculations are not well grounded.

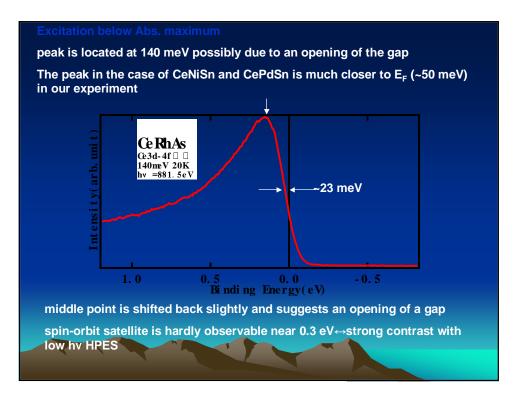


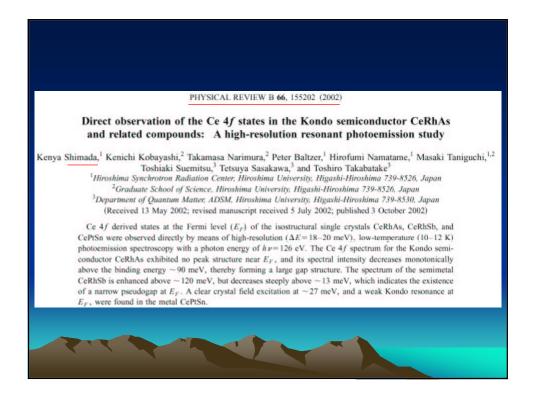


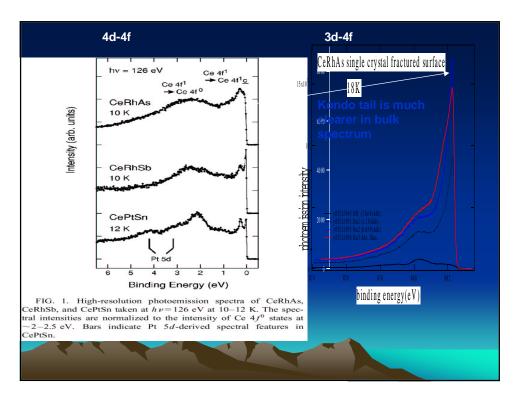


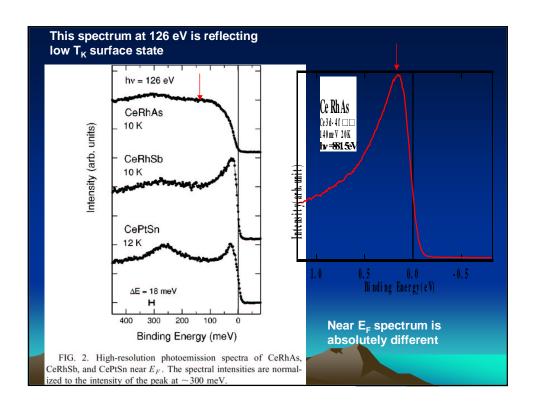


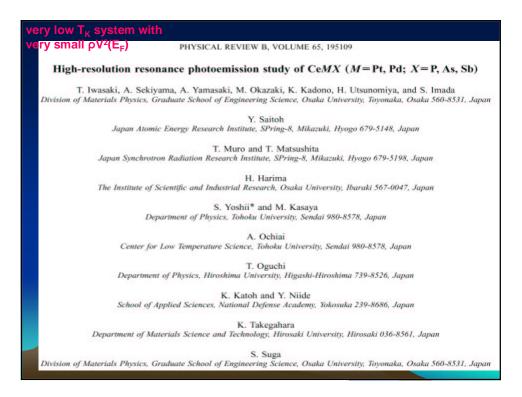


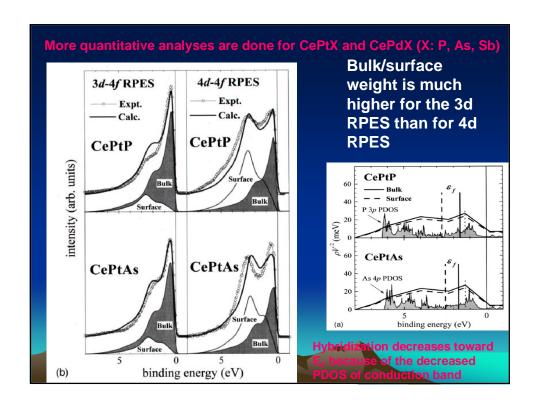


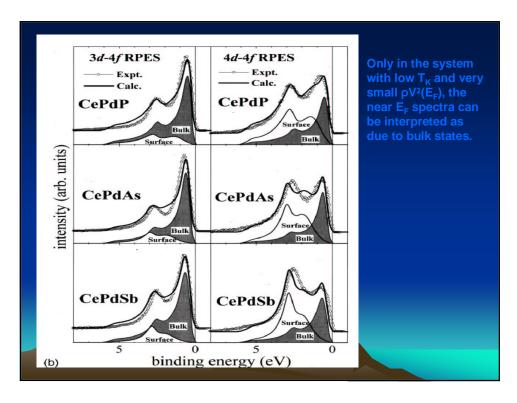












Summary

- Soft X-ray high resolution photoemission spectroscopy (both angle integrated and resolved) can provide very important information on bulk electronic states of RE and TM compounds
- Feasibility of soft X-ray ARPES for band mapping and Fermiology is demonstrated for the first time
- Re-examination of electronic structures of many correlated electron systems by this technique is inevitable